FXE instrument summary: Solid State Sample Environments and –Techniques for grazing incidence experiments





Standard Setup: Kappa Goniometer for Simultaneous XRD & XAS/XES



European XFEL

Diffraction angles 20 from 0-160°, radius up to 0.6 m

- Sample orientation from grazing incidence to -exit
- s- or p-polarized diffraction
- Can be combined with either Johan or von Hamos spectrometer (if E_{ph, emission} > ~8 keV)
- JF1M dictates train structure: 16 pulses @ 94 kHz
- Sample microscopes along 3 axes
- Cryo-blower as an option
- Colinear pump



Standard Setup: Helium Goniometer for Simultaneous XRD & XAS/XES



European XFEL

Mostly in combination with spectroscopy at <~8 keV</p>

- Diffraction angles 2θ from 0 to ~60°
 - p-polarized diffraction only (at present)
 - s-polarized diffraction gives better stability
- Can be combined with von Hamos spectrometer or TFY detection

He path available for E_{ph, emission} > ~5 keV

- JF1M or LPD
- Colinear pump
- Sample microscopes along 2 axes
- No option for PAM (currently)

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Custom Setup: Grazing Incidence XRD at cryo temperatures



- Ideal for low-background grazing incidence measurements (up to θ ~10°)
- 20 limited by window geometry to ~60° (10A⁻¹ at 20 keV)
- Cryogenic sample holder (100 K to 400 K)
 - Option for in-situ deposition (to be provided by users)
 - Large sample translation range (in case of damage)
- Colinear pump
- Sample microscope along 1 axis
- No option for PAM (currently)

Standard Setup: Vacuum Chamber for Transmission-mode XRD



- Ideal for low-background measurements
- Transmission mode scattering using LPD (or JF1M)
- 20 limited by window geometry to ~50° (8A⁻¹ at 20 keV)
- Usually single shot (one pump-probe event per sample spot)
 - Sample scanner* with absolute encoders
 - Scan speed of 1 Hz (limited by Karabo/Karabacon)
- Colinear pump
- Sample microscope along 1 axis
- No option for PAM (currently)

*Sample scanner developed by SEC group

Potential future option: Transmission-mode XAS in grazing incidence

- Using pink beam \rightarrow efficient data collection (and high resolution)
- Mount thin film sample on goniometer,
 - Total reflection from the (denser) substrate can yield long transmission path
- Yet to be tested (homogeneity of X-ray spectrum?)



Custom Setup: Transmission-mode scattering with rotation (Xtras RnD)



- Shorter range xy sample scanner*
- Rotation angles +/-30° for epitaxial films
- Colinear pump
- Sample microscope along 1 axis
- No option for PAM (currently)

European XFEL

*Sample scanner developed by SEC group

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Foreseen: Helium/Vac compatible Euler goniometer with T-control option



- Goal: overcome the limited angle of incidence when using Helium sample environment
- Design ongoing with Huber and Kohzu

FXE: Grazing Incidence Techniques

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FXE: Operation Envelope

Photon Energy 5 to 20 keV (limited by focusing optics, 23 keV limit due to coating of M3)



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